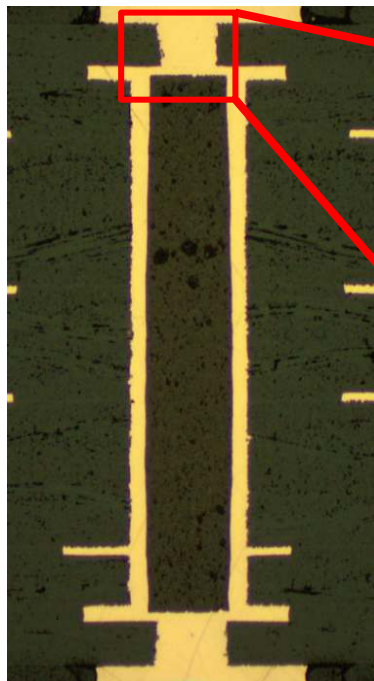


Recommendations/comments on “IPC-2226”

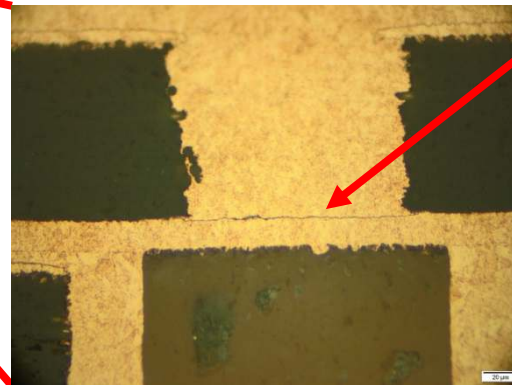
(Implementation subject to customer/supplier agreement)

Objective:

- Increase the reliability of electronic components
- Reduce the risk of copper disconnection due to thermal stress during the soldering process

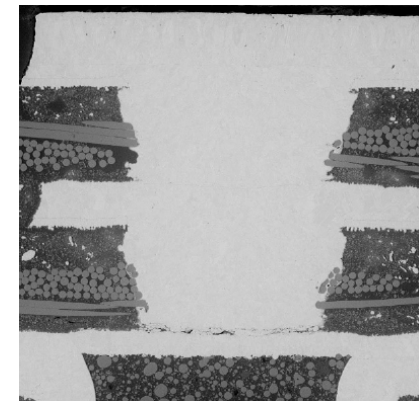


Source: PCB Quality Working Group



Source: PCB Quality Working Group

Delamination after thermal stress exposure



Source: Bill Birch,
PWB Interconnect Solutions Inc.

Recommendations/comments on “IPC-2226”

(Implementation subject to customer/supplier agreement)

Excerpt from IPC-2226:

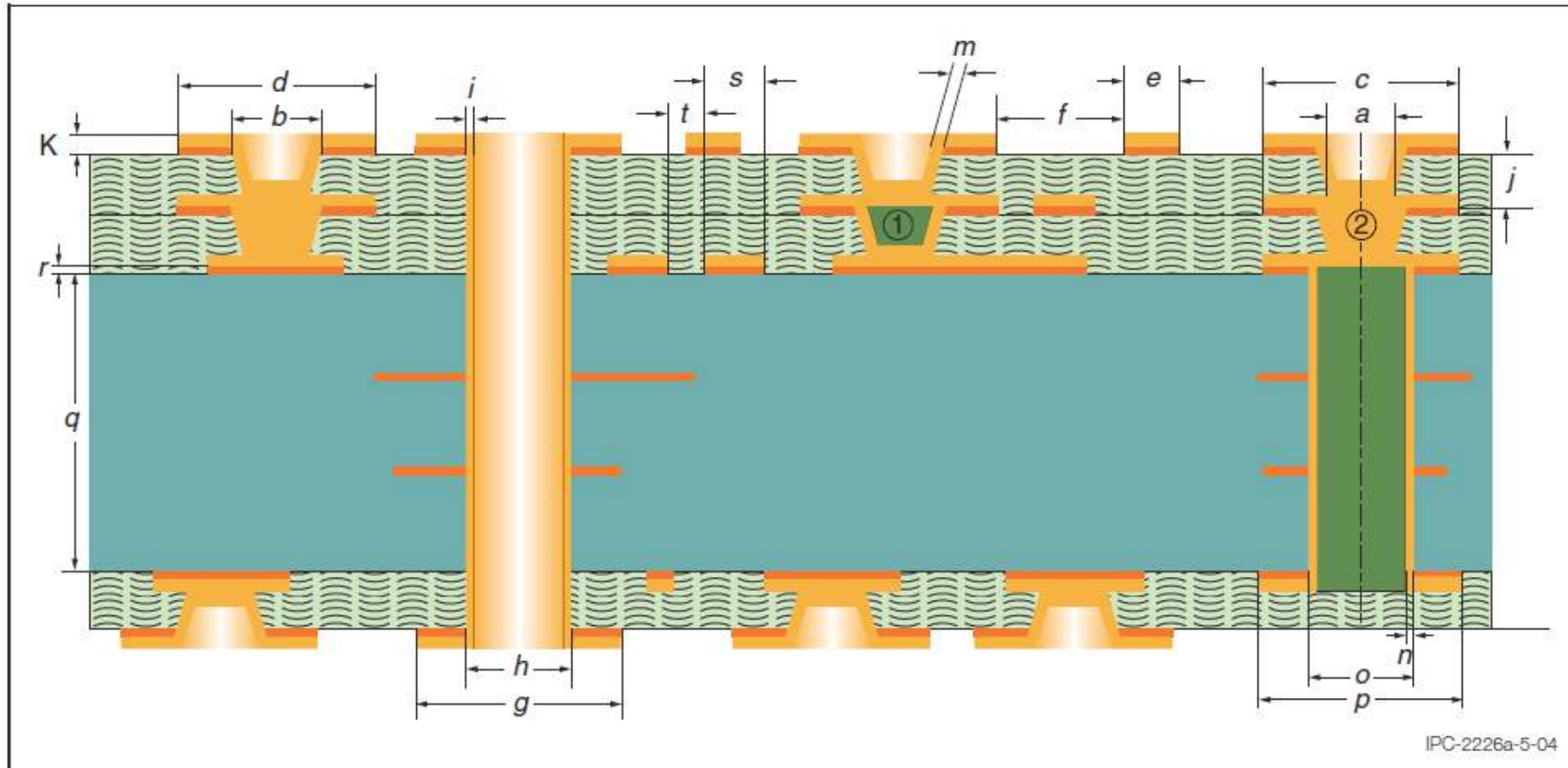


Figure 5-4 Type III HDI Construction with Stacked Microvias

(Caution: Unbalanced constructions as shown above may result in excessive bow and twist.)

Note 1: Stacking not recommended for resin or conductive/non-conductive filled microvias.

Note 2: Stacking not recommended over resin or conductive/non-conductive filled vias due to potential for reduced reliability. Instead, the use of staggered structures is recommended.

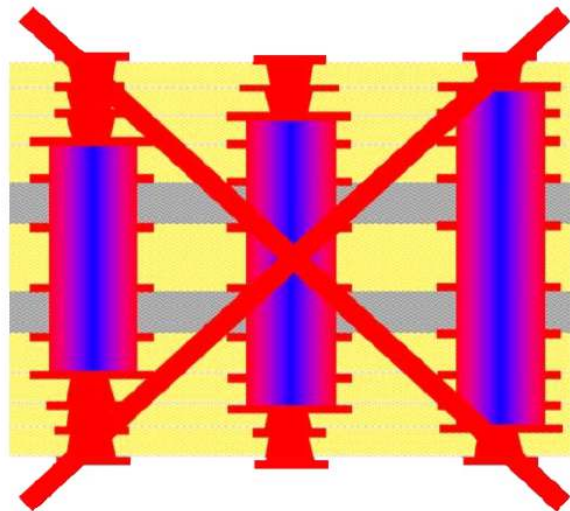
Caution: HDI design with microvias stacked on buried resin filled vias is not recommended.

Recommendations/comments on “IPC-2226”

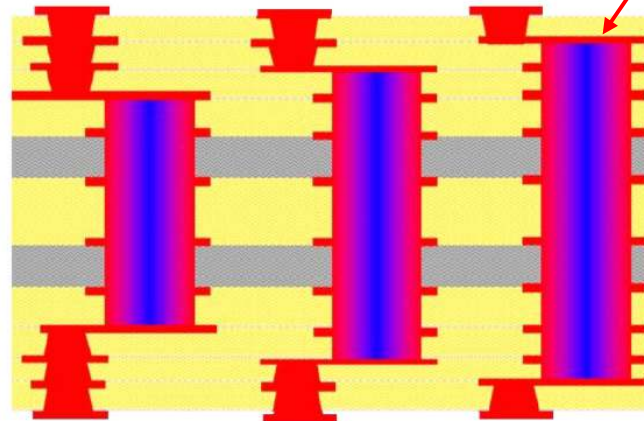
(Implementation subject to customer/supplier agreement)

Recommendation for implementing IPC-2226:

Arranging stacked microvias and resin-filled buried vias in a staggered layout.



Source (2): PCB Quality Working Group



Note:

The copper cap of the resin filled vias is not necessary for the implementation of this recommendation.